Notice of References Cited Application/Control No. 10/724,846 Examiner Ly T. TRAN Applicant(s)/Patent Under Reexamination HOSHINO ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0080598	04-2004	Hasebe et al.	347/102
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